

September 2008

FDMS9600S Dual N-Channel PowerTrench[®] MOSFET

Q1: 30V, 32A, 8.5m Ω Q2: 30V, 30A, 5.5m Ω

Features

Q1: N-Channel

- Max $r_{DS(on)}$ = 8.5m Ω at V_{GS} = 10V, I_D = 12A
- Max $r_{DS(on)}$ = 12.4m Ω at V_{GS} = 4.5V, I_D = 10A

Q2: N-Channel

- Max $r_{DS(on)}$ = 5.5m Ω at V_{GS} = 10V, I_D = 16A
- Max $r_{DS(on)}$ = 7.0m Ω at V_{GS} = 4.5V, I_D = 14A
- Low Qg high side MOSFET
- Low r_{DS(on)} low side MOSFET
- Thermally efficient dual Power 56 package
- Pinout optimized for simple PCB design
- RoHS Compliant

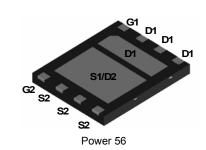
General Description

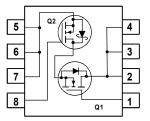
This device includes two specialized MOSFETs in a unique dual Power 56 package. It is designed to provide an optimal Synchronous Buck power stage in terms of efficiency and PCB utilization. The low switching loss "High Side" MOSFET is complemented by a Low Conduction Loss "Low Side" SyncFET.

Applications

Synchronous Buck Converter for:

- Notebook System Power
- General Purpose Point of Load





MOSFET Maximum Ratings T_A = 25°C unless otherwise noted

Symbol	Parameter		Q1	Q2	Units
V _{DS}	Drain to Source Voltage		30	30	V
V _{GS}	Gate to Source Voltage		±20	±20	V
	Drain Current -Continuous (Package limited) T _C = 25°C		32	30	
1	-Continuous (Silicon limited) T _C = 25°C		55	108	^
Ъ	-Continuous T _A = 25°C	(Note 1a)	12	16	A
	-Pulsed		60	60	_
D	Power Dissipation for Single Operation	(Note 1a)	2.	5	w
P _D		(Note 1b)	1.	.0	vv
T _J , T _{STG}	Operating and Storage Junction Temperature Range		-55 to	+150	°C

Thermal Characteristics

$R_{ ext{ heta}JA}$	Thermal Resistance, Junction to Ambient (Note 1a)	la) 50		
R_{\thetaJA}	Thermal Resistance, Junction to Ambient (Note 1b)	b) 120 °(°C/W
$R_{ ext{ heta}JC}$	Thermal Resistance, Junction to Case	3 1.2		

Package Marking and Ordering Information

Γ	Device Marking	Device	Package	Reel Size	Tape Width	Quantity
	FDMS9600S	FDMS9600S	Power 56	13"	12mm	3000 units

Symbol	Parameter	Test Conditions	Туре	Min	Тур	Мах	Units
Off Chara	acteristics						
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0V$ $I_D = 1mA, V_{GS} = 0V$	Q1 Q2	30 30			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D = 250\mu$ A, referenced to 25°C $I_D = 1$ mA, referenced to 25°C	Q1 Q2		35 29		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 24V, V _{GS} = 0V	Q1 Q2			1 500	μA
I _{GSS}	Gate to Source Leakage Current	V _{GS} = ±20V, V _{DS} = 0V	Q1 Q2			±100 ±100	nA nA
On Chara	cteristics						
V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}$, $I_D = 250\mu A$ $V_{GS} = V_{DS}$, $I_D = 1mA$	Q1 Q2	1 1	1.5 1.8	3 3	V
$rac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D = 250\mu$ A, referenced to 25°C $I_D = 1$ mA, referenced to 25°C	Q1 Q2		-4.5 -6.0		mV/°C
	Durin to Course On Desistance	$V_{GS} = 10V, I_D = 12A$ $V_{GS} = 4.5V, I_D = 10A$ $V_{GS} = 10V, I_D = 12A, T_J = 125^{\circ}C$	Q1		7.0 9.2 8.6	8.5 12.4 13.0	
r _{DS(on)} Drain to Source On Resistance	$V_{GS} = 10V, I_D = 16A$ $V_{GS} = 4.5V, I_D = 14A$ $V_{GS} = 10V, I_D = 16A, T_J = 125^{\circ}C$	Q2		4.5 5.3 5.4	5.5 7.0 8.3	- mΩ	
9 _{FS}	Forward Transconductance	$V_{DD} = 10V, I_D = 12A$ $V_{DD} = 10V, I_D = 16A$	Q1 Q2		54 68		S

Dynamic Characteristics

C _{iss}	Input Capacitance		Q1 Q2	1280 2300	1705 3060	pF
C _{oss}	Output Capacitance	V _{DS} = 15V, V _{GS} = 0V, f= 1MHz	Q1 Q2	525 1545	700 2055	pF
C _{rss}	Reverse Transfer Capacitance		Q1 Q2	80 250	120 375	pF
R _g	Gate Resistance	f = 1MHz	Q1 Q2	1.0 1.7		Ω

Switching Characteristics

t _{d(on)}	Turn-On Delay Time		Q1 Q2	13 17	23 31	ns
t _r	Rise Time	V _{DD} = 10V, I _D = 1A,	Q1 Q2	6 11	12 20	ns
t _{d(off)}	Turn-Off Delay Time	$V_{GS} = 10V, R_{GEN} = 6\Omega$	Q1 Q2	42 54	67 86	ns
t _f	Fall Time		Q1 Q2	12 32	22 51	ns
Q _{g(TOT)}	Total Gate Charge	Q1 V _{DD} = 15V, V _{GS} = 4.5V, I _D = 12A	Q1 Q2	9 21	13 29	nC
Q _{gs}	Gate to Source Gate Charge	Q2	Q1 Q2	3 8		nC
Q _{gd}	Gate to Drain "Miller" Charge	V _{DD} = 15V, V _{GS} = 4.5V, I _D = 16A	Q1 Q2	2.7 6.5		nC

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Symbol	Parameter	Test Conditions		Туре	Min	Тур	Мах	Units
Drain-Sou	urce Diode Characteristics							
I _S	Maximum Continuous Drain-Source Dio	de Forward Current		Q1 Q2			2.1 3.5	А
V _{SD}	Source to Drain Diode Forward Voltage	$\label{eq:VGS} \begin{array}{ll} V_{GS} = 0V, \ I_S = 2.1A & (N \\ V_{GS} = 0V, \ I_S = 3.5A & (N \\ V_{GS} = 0V, \ I_S = 8.2A & (N \\ \end{array}$	Note 2) Note 2) Note 2)	Q1 Q2 Q2		0.7 0.4 0.5	1.2 1.0 1.0	v
t _{rr}	Reverse Recovery Time	Q1 I _F = 12A, di/dt = 100A/μs		Q1 Q2		33 27		ns
Q _{rr}	Reverse Recovery Charge	Q2 I _F = 16A, di/dt = 300A/μs		Q1 Q2		20 33		nC

Notes:
R_{0JA} is determined with the device mounted on a 1in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R_{0JC} is guaranteed by design while R_{0CA} is determined by the user's board design.



2: Pulse Test: Pulse Width < 300µs, Duty cycle < 2.0%.

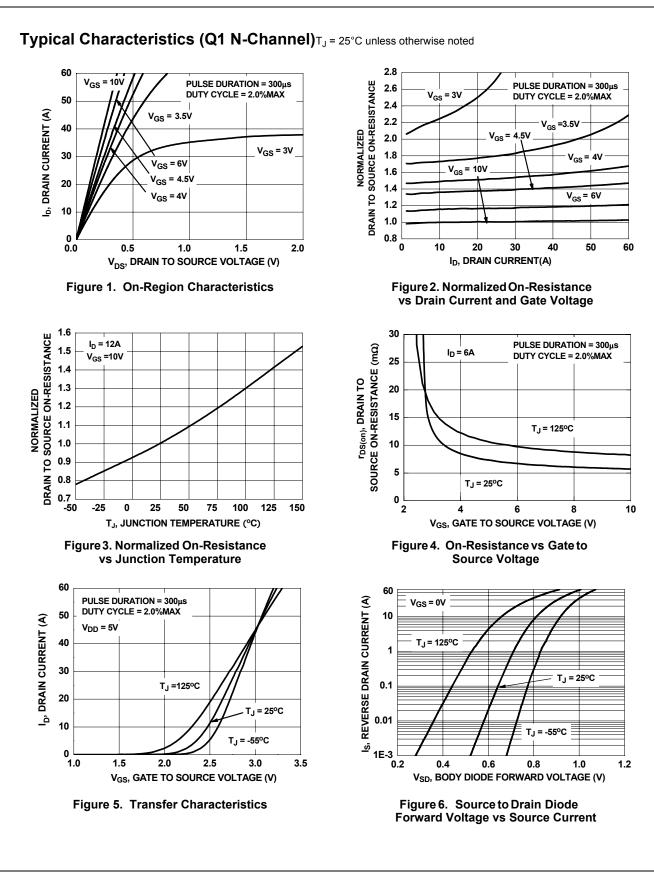
a.50°C/W when mounted on a 1 in² pad of 2 oz copper



b. 120°C/W when mounted on a minimum pad of 2 oz copper

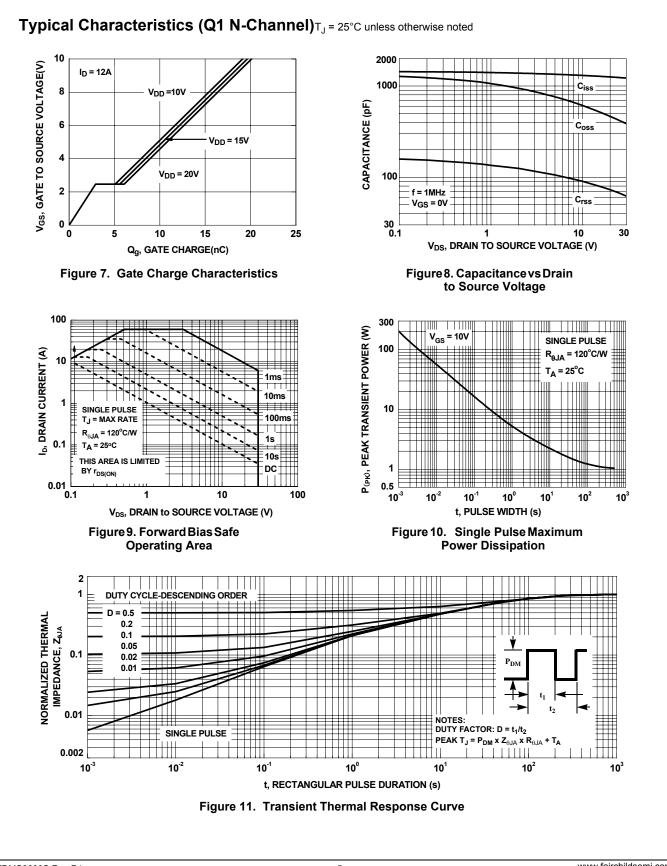
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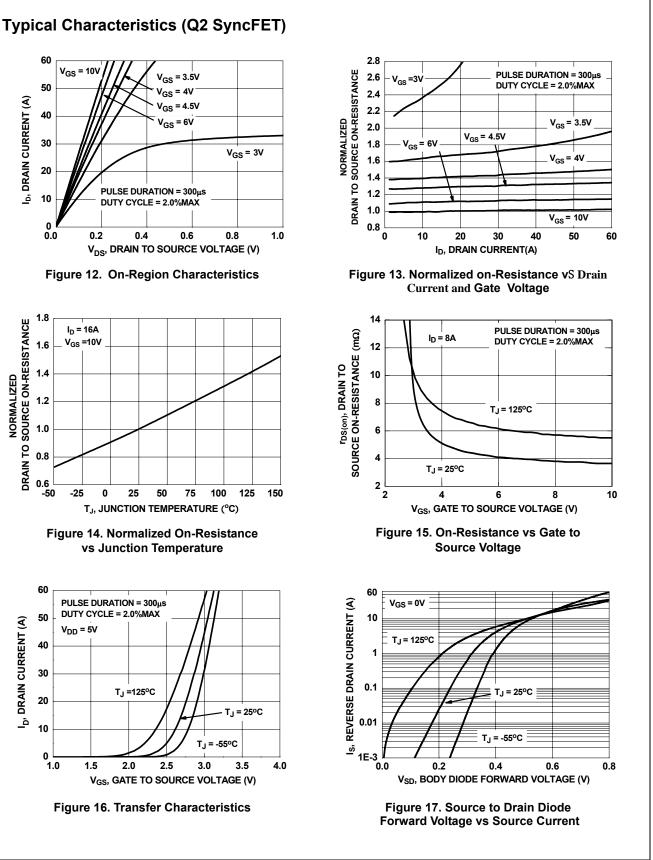


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FDMS9600S Dual N-Channel PowerTrench[®] MOSFET



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60

50

40

30

20

10

Λ

0.0

1.8

1.6

1.4

1.2

1.0

0.8

0.6 -50

60

50

40

30

20

10

0 1.0

I_D, DRAIN CURRENT (A)

-25

V_{DD} = 5V

1.5

DRAIN TO SOURCE ON-RESISTANCE

NORMALIZED

ID, DRAIN CURRENT (A)

V_{GS} = 10V

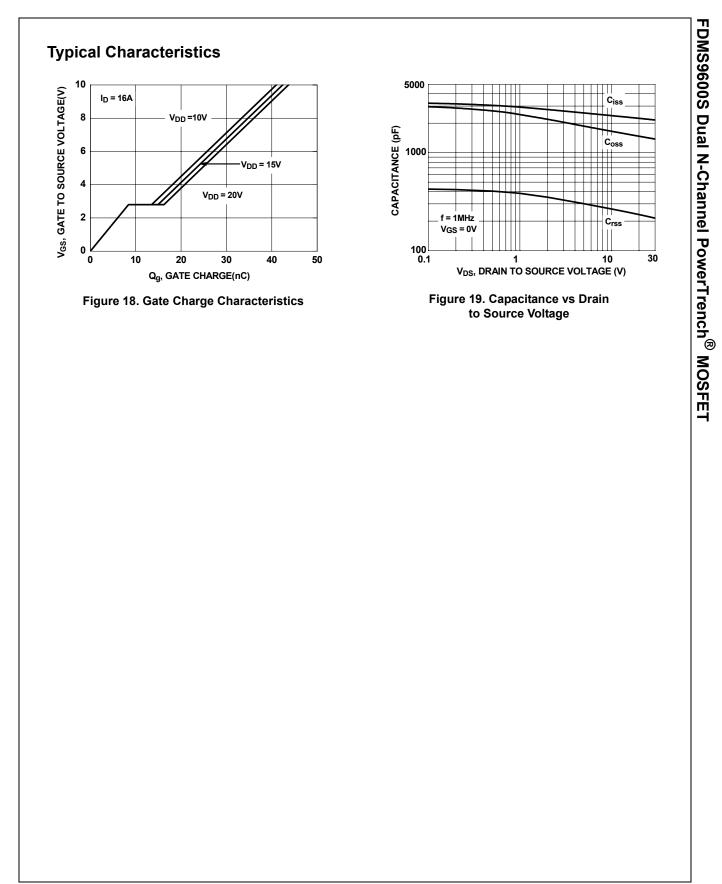
0.2

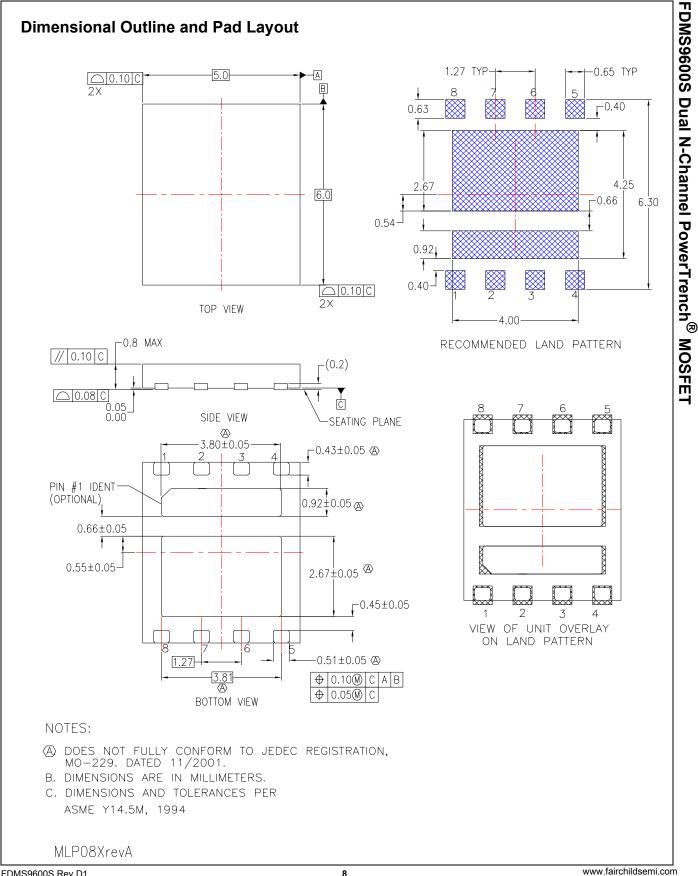
I_D = 16A

V_{GS} =10V

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